

FCC TEST REPORT

For

Shantou Chaoyang District Shengtena Electronic Factory

Bluetooth Earphone

Model No.: STN-888, STN-777, STN-861, V91, V92, V93, V1, V2, V51, VK89, V95, V96, V97, V111, V333, W1

Prepared For : Shantou Chaoyang District Shengtena Electronic Factory

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City Guangdong Province, China 515159

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Date of Receipt : Nov. 21, 2018

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Date of Report : Dec. 06, 2018



Contents

1. General Information	-,00	, Vo.	"Hyore"	WUL	(e)k	abotek	5
1.1. Client Information	An	~10H	* upotek	- Fupc	Y-	" Notel	5
1.1. Client Information 1.2. Description of Device (EUT) 1.3. Auxiliary Equipment Used During Test 1.4. Description of Test Modes 1.5. List of channels	24	, o.Y.	, , , , , , , , , , , , , , , , , , ,	<u>6</u>	100fe	VUr.	5
1.3. Auxiliary Equipment Used During Test		Aupore	An	-18k	* upotek		5
1.4. Description of Test Modes		otel	e Mp		P1.	d _{II} ,	6
1.5. List of channels 1.6. Description Of Test Setup	Vupo.	po.	, Nay	nhotei	Anb	16/	7
1.6. Description Of Test Setup	Anhote	Ans		, npotek	dn.q	D	8
1.7. Test Equipment List			upo.			"pote"	9
1.8. Description of Test Facility		okek	Kupo _{te} ,	Pur.		gotek	10
2. Summary of Test Results	P _U		potel	24	por	br	11
3. Conducted Emission Test	otek	Anbo	b.,	199	Aupoter.	Anb	12
3.1. Test Standard and Limit	Horek	Ropote.	Ans		atel	Anb	12
3.2. Test Setup	7412		tek V	Upor	b.,.	, w. Yay	12
3.2. Test Setup	Anbo		Hotek	popote.	Ant.	V93	12
3.4 Test Data							12
4. Radiation Spurious Emission and Band Edge.	Yy	otek	Aupo.	ps	orek	Rapoter	17
4. Radiation Spurious Emission and Band Edge. 4.1. Test Standard and Limit		wotek.	Mpote,	An		, botel	17
4.2. Test Setup	0,00	Yur.	٥٥,,,,	tek	Aupor	b21.	17
4.3. Test Procedure	abotek	Anbo	bo.	uotek.	*upote,	Ann	18
4.4 Test Data		apo					nb0 10
Maximum Peak Output Power Test Test Standard and Limit	Vur.	<i>K</i>	botek	Anbor		.otek	27
5.1. Test Standard and Limit	Anbo		wotek.	*John P. John	P.		27
5.1. Test Standard and Limit	r Pup	ole.	An-		otek	Aupor	27
5.3. Test Procedure	, oK	obotek	Anbo		uotek	Anhote.	27
5.4. Test Data		, notek	Anbo		Yur Yek	,50	27
6.1. Test Standard	whole.	And		otek	VUPO	b.	31
6.2. Test Setup	n. wotel	4 An	pore	Vur.	<i>Y</i> -	potek	31
to a large and a seek above							
6.3. Test Procedure	Anb		, otek	Ank	,oto	Ann	31
7. Carrier Frequency Separation Test	tek b	upore	A.C.	o.K	nbotek	Aupo	35
7.1. Test Standard and Limit	Nek-	anboten	Anbe		, botek	Anbo	35
7.2. Test Setup	,p=	bot	ek An'	OOL	A.r.	o. Y	35
7.3. Test Procedure	Anbore	bit.	1eK	anbotek	Anbo	V	35
7.4. Test Data	Vupote,	An		r wote	K AN	ore	35
8. Number of Hopping Channel Test		tek	Anbole	VII.	rek	anbotek	39
8.1. Test Standard and Limit	br.	otek	Anbotek	Anb		hotek	39
8.2. Test Setup	(8 P.	us-	hoti	,K	nbore	Arres	39
8.3. Test Procedure	botek	Anbot	bu.	otek	Anbotek	Anbie	39
8.4. Test Data	otek.	Anbote	An		hot	k An	39
8.1. Test Standard and Limit	Anb		otek	Aupor	Pu	otek	41
9 1 Test Standard and Limit	Anbow	K	· otek	Anbote	Ant	rok.	41
,		(C.	CUD		-Va-	401	VII.



9.2. Test Setup	An Hotek	Apporek	Anbo	W. Workey	Anbote,	.42
9.3. Test Procedure	Ann	, upotek	Anbos	br. cotek	_{kobote}	.42
9.4. Test Data	tek Anbo		k bulbose.	Anv		4:
10. 100kHz Bandwidth of Frequency B	and Edge Requir	ement	³¹ 2d ₁₁₁	Anbo		45
10.1. Test Standard and Limit		Pofer Vup.		ote ^k 2010	oto p	.45
10.2. Test Setup	Aupe H	- Jolek	upore, Vui		Kubotek	.45
10.3. Test Procedure	Aupore	br.,	-Kupoter	^{Tup} n	Hotek	.45
10.4. Test Data		Anb	gotek	Anbore	Villa Go	45
11. Antenna Requirement		Vupor.	by. Yok	Minotek	Anbe	.50
11.1. Test Standard and Requirement	ent	ek "pote"	And	2000	k Pup.	50
11.2. Antenna Connected Construc	ction		itek Aupore			50
APPENDIX I TEST SETUP PHOTO	GRAPH	oor. En	den Yay	oten Anb	······································	52
APPENDIX II EXTERNAL PHOTO	GRAPH		Up.	tootek !	Wpore.	53
APPENDIX III INTERNAL PHOTO	GR A PH					56



TEST REPORT

Applicant : Shantou Chaoyang District Shengtena Electronic Factory

Manufacturer : Shantou Chaoyang District Shengtena Electronic Factory

Product Name : Bluetooth Earphone

Model No. STN-888, STN-777, STN-861, V91, V92, V93, V1, V2, V51, VK89, V95, V96, V97,

V111, V333, W1

Trade Mark : N.A.

Rating(s) : Input: DC 5V, 100mA(with DC 3.7V, 70 mAh Battery inside)

Test Standard(s) : FCC Part15 Subpart C 2018, Section 15.247

Test Method(s) : **ANSI C63.10: 2013**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test	Anbo	Nov. 21~Dec. 06, 2	018
MBOT		olivay an	Anbotek Anbotek
Prepared by Anboto	S	My CON I	Anbotek Anbote
FIC		(Engineer / Oliay Y	ang)
Anbotek Anbotek Anbotek	hotek Anbotek Anb	o ^{to} AAa	a otek anbotek
Reviewer	Anbotek Anbotek A	Snavy Me	Anbotek Anbotek
ek Anbotes Anbotek	Anbotek Anbotek	(Supervisor / Snowy I	Meng)
		Sally Zhou	ng k kupotek A
Approved & Authorized Signer		hotek Anbotek	Motek Anbotek
	Anbotek Anbote A	(Manager / Sally Zh	ang) handa kanada k

1. General Information

1.1. Client Information

Applicant	Shantou Chaoyang District Shengtena Electronic Factory
Address	Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou City Guangdong Province, China 515159
Manufacturer	: Shantou Chaoyang District Shengtena Electronic Factory
Address	Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou City Guangdong Province, China 515159
Factory	Shantou Chaoyang District Shengtena Electronic Factory
Address	Gounan Village Industrial Area, Gurao Town, Chaoyang District, Shantou City Guangdong Province, China 515159

1.2. Description of Device (EUT)

	Product Name	:	Bluetooth Earphone	Anbotek Anbotek Anbotek Anbo
1	Model No.	:	V97, V111, V333, W1	91, V92, V93, V1, V2, V51, VK89, V95, V96, except the model name, so we prepare "STN-888"
K	Trade Mark	:	N.A. Andrew Ambotek	Anbotek Anbotek Anbotek Anbo
0	Test Power Supply	:	AC 240V, 60Hz for adapter/ AC	120V, 60Hz for adapter/ DC 3.7V Battery inside
S)	Test Sample No.	:	S1(Normal Sample), S2(Engineer	ring Sample)
			Operation Frequency:	2402MHz~2480MHz
			Transfer Rate:	1/2 Mbits/s
	Product Description		Number of Channel:	79 Channels
i'c			Modulation Type:	GFSK, π/4-DQPSK
50			Antenna Type:	PCB Antenna
			Antenna Gain(Peak):	-3.27 dBi

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

	Adapter	:	Manufacturer: ZTE	
			M/N: STC-A2050I1000USBA-C	
			S/N: 201202102100876	
			Input: 100-240V~50/60Hz 0.3A	Š
Ç.S			Output: DC 5V, 1000mA	

1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	botek Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Mode 2	CH39 Anbotek Anbotek Anbotek
Mode 3	CH78 Anbotek Anbotek Anbotek
Mode 4	Keeping TX+ Charging Mode

	For Conducted Emission	
Final Test Mode	Description	
Mode 4	Keeping TX+ Charging Mode	Anbo

	For Radiated Emission							
F	inal Test Mo	de	Description					
Aupor	Mode 1	stek Ar	poter Andrew CH00 poter Andrew Andrew					
Anbo	Mode 2	nbotek	Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek					
olek Ar	Mode 3	anbotek	Anborte Anborek Anborek An					
Noter	Mode 4	Anbotek	Keeping TX+ Charging Mode					

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
- (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.



1.5. List of channels

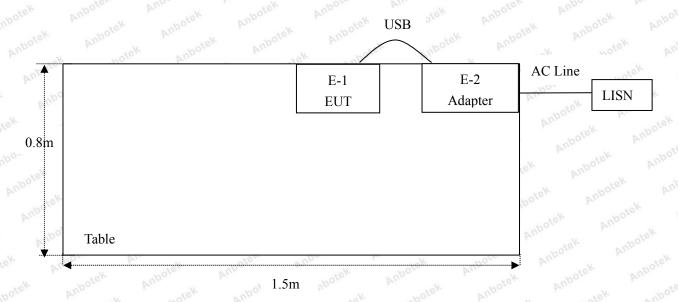
Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.
	(MHz)		(MHz)		(MHz)		(MHz)		(MHz)
00	2402	Anb 97	2419	34	2436	¹⁰⁰ 51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21 An	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05	2408	23	2425	40	2442	57	2459	74	2476
tel 07 AT	2409	24	2426	41 Anio	2443	58	2460	75	2477
08	2410	25	2427	42	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	ote*77	2479
Anolo	2412	× 27 m	2429	44	2446	61 nb0	2463	78	2480
PPOLO	2413	28	2430	45	2447	62	2464		
12	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47	2449	64	2466		
14	2416	31	2433	48	2450	65	2467	1 nb	
bote 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

Note:

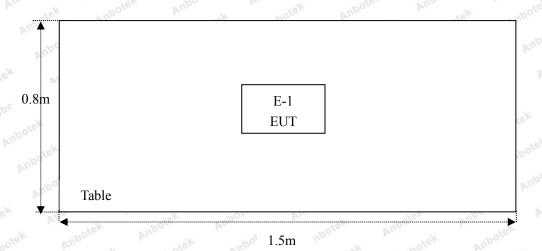
- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

1.6. Description Of Test Setup

CE



RE





1.7. Test Equipment List

Y	- K 5010	VILLE	100°	PS:	7,6,,	VUD.
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
otek 1. Inbotek	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 05, 2018	1 Year
2.00	EMI Test Receiver	Rohde & Schwarz	ESPI3	101604	Nov. 05, 2018	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 05, 2018	1 Year
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 05, 2018	1 Year
o ^{tek} 5.	MAX Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 05, 2018	1 Year
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 05, 2018	1 Year
Anbou 7.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2018	1 Year
8.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 19, 2018	1 Year
9.	Loop Antenna	Schwarzbeck	FMZB1519B	00053	Nov. 20, 2018	1 Year
10.	Horn Antenna	A-INFO	LB-180400-K F	J211060628	Nov. 20, 2018	1 Year
11.,,,	Pre-amplifier	SONOMA	310N	186860	Nov. 05, 2018	1 Year
12.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
13.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 05, 2018	1 Year
14.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 05, 2018	1 Year
15.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 05, 2018	1 Year
16.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 05, 2018	1 Year
17.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 05, 2018	1 Year
18.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 05, 2018	1 Year
19.	DC Power Supply	IVYTECH	IV3605	1804D360510	Apr. 02, 2018	1 Year
20.	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS80B	N/A	Nov. 01, 2018	1 Year



1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Test Item	Result
Antenna Requirement	PASS
Conducted Emission	PASS
Spurious Emission	PASS
Conducted Peak Output Power	PASS
20dB Occupied Bandwidth	PASS
Carrier Frequencies Separation	PASS
Hopping Channel Number	PASS
Dwell Time	PASS
Band Edge	PASS
	Antenna Requirement Conducted Emission Spurious Emission Conducted Peak Output Power 20dB Occupied Bandwidth Carrier Frequencies Separation Hopping Channel Number Dwell Time



3. Conducted Emission Test

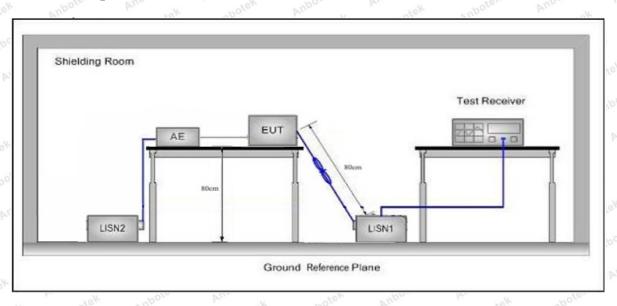
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.207	Anbore Ans botek	Anbotek Anbo stek				
	Eraguanav	Maximum RF Line Voltage (dBuV)					
	Frequency	Quasi-peak Level	Average Level				
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *				
	500kHz~5MHz	56 Sec. 1	46				
	5MHz~30MHz	60	50				

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages.

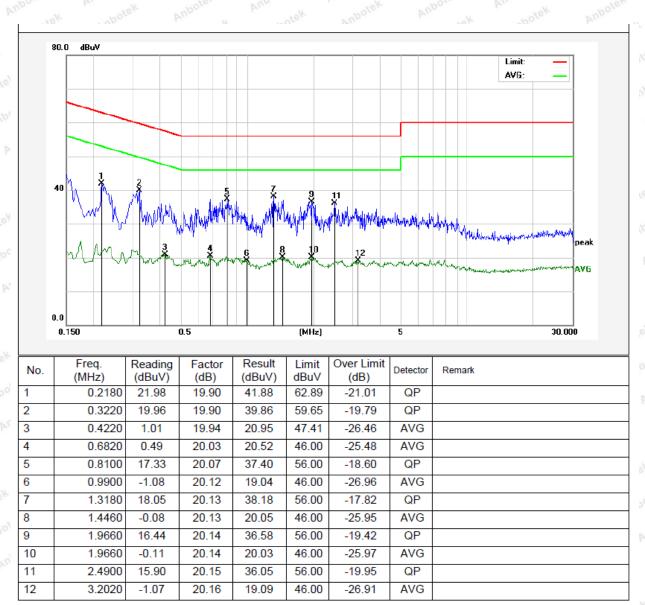


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

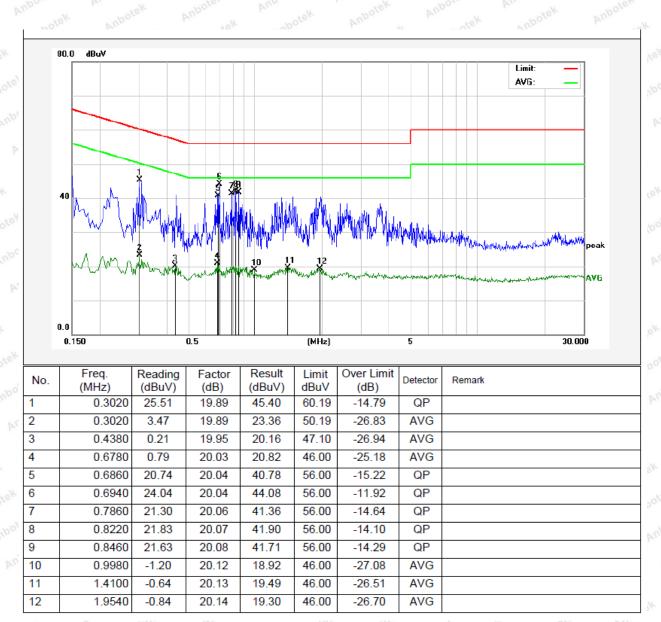


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode AC 240V, 60Hz for adapter Test Specification:

Comment: Neutral Line



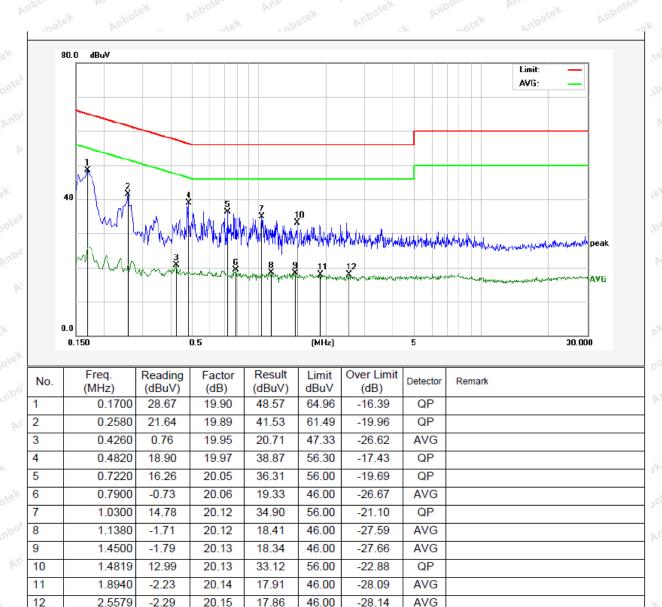


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Live Line

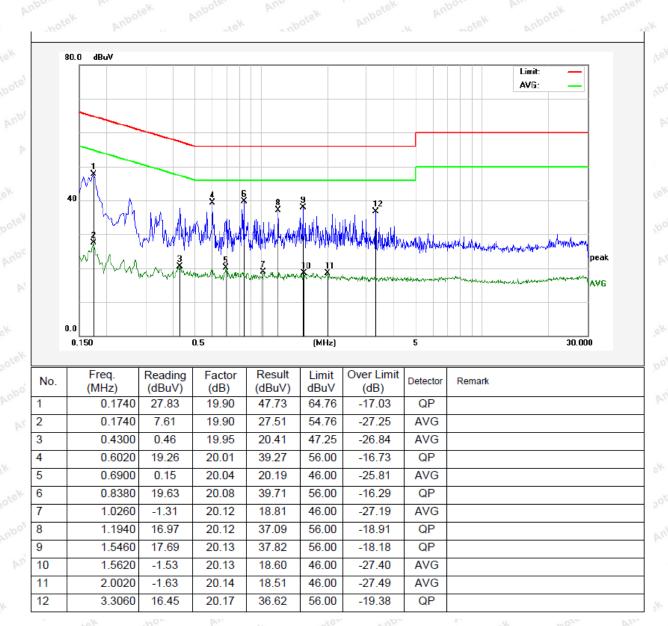


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 120V, 60Hz for adapter

Comment: Neutral Line





4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	09 and 15.205	Anshotek	Anbotek P	upo, k.
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	ibotek - Anbo	e Aus	300
	0.490MHz-1.705MHz	24000/F(kHz)	Aupotek Ar	Pose Vin	30
	1.705MHz-30MHz	30	Anbatek	Aupor A	30
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	3.ek
	88MHz~216MHz	150	43.5	Quasi-peak	3 _{botek}
	216MHz~960MHz	200	46.0	Quasi-peak	ek 3 potek
	960MHz~1000MHz	500	54.0	Quasi-peak	atek 3 anbo
	Ahana 1000MII-	500	54.0	Average	3
	Above 1000MHz	botek - Anbot	74.0	Peak	3

Remark:

- (1) The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

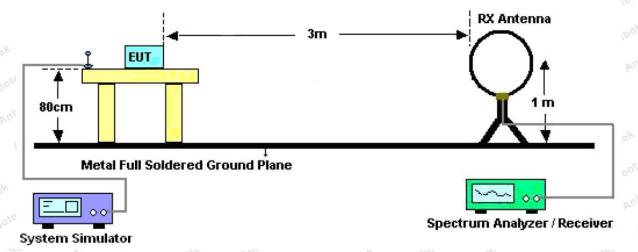


Figure 1. Below 30MHz



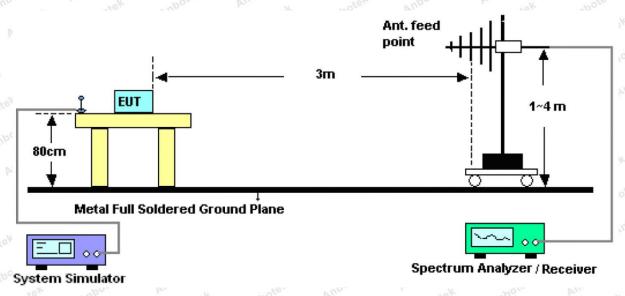


Figure 2. 30MHz to 1GHz

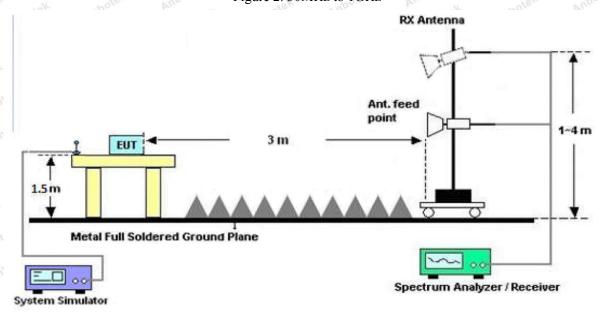


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying



aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, $\pi/4$ QPSK modulation, and found the GFSK modulation Middle channel which is the worst case, only the worst case is recorded in the report

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

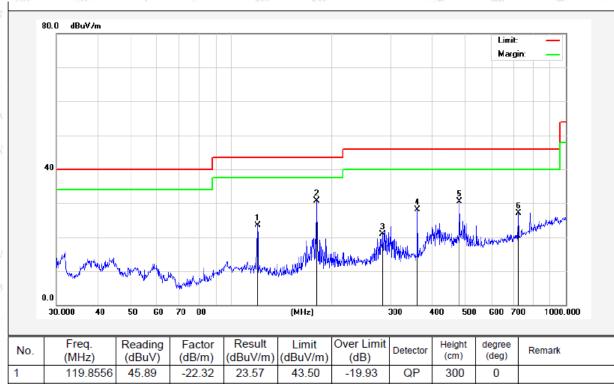
Note: The data is in TX only mode, and this is the worst mode.

Test Results (30~1000MHz)

Job No.: SZAWW181121004-01 Temp.(°C)/Hum.(%RH): 24.2°C/54%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Horizontal



No.	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	Detector	(cm)	(deg)	Remark
1	119.8556	45.89	-22.32	23.57	43.50	-19.93	QP	300	0	
2	180.0165	51.46	-20.85	30.61	43.50	-12.89	QP	300	74	
3	283.9791	39.86	-18.95	20.91	46.00	-25.09	QP	300	199	
4	360.4476	42.09	-14.05	28.04	46.00	-17.96	QP	300	299	
5	480.5276	42.04	-11.53	30.51	46.00	-15.49	QP	300	341	
6	721.7259	35.21	-8.05	27.16	46.00	-18.84	QP	300	360	

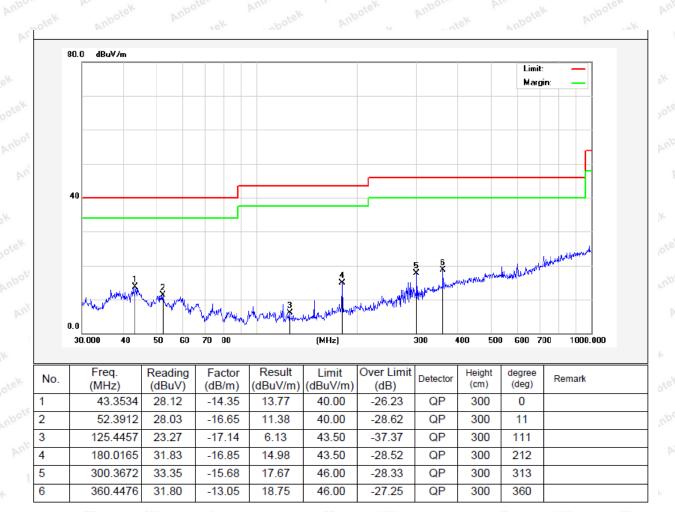


Test Results (30~1000MHz)

Job No.: SZAWW181121004-01 Temp.(°C)/Hum.(%RH): 24.2°C/54%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Vertical





Test Results (1GHz-25GHz)

Test Mode: (CH00			Test	channel: Lowe	st		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	37.77	34.04	6.58	34.09	44.30	74.00	-29.70	boteV
7206.00	32.14	37.11	7.73	34.50	42.48	74.00	-31.52	Valo
9608.00	31.74	39.31	9.23	34.79	45.49	74.00	-28.51	V
12010.00	***************************************	tek	abotek p	upor	An	74.00	Anboatek	V
14412.00	* Anti	ntek .	nbotek	Anbotek	Ann	74.00	Anbor	v V
4804.00	42.15	34.04	6.58	34.09	48.68	74.00	-25.32	Н
7206.00	33.93	37.11	7.73	34.50	44.27	74.00	-29.73	H
9608.00	31.21	39.31	9.23	34.79	44.96	74.00	-29.04	Anboto H
12010.00	* Anbote	Anbo	rek Vi	botek	Anboten	74.00	anbotek	HA
14412.00	cek * Anbo	Vek by	100r B	potek	Anboren	74.00	anbotek	H×
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	26.50	34.04	6.58	34.09	33.03	54.00	-20.97	V
7206.00	20.77	37.11	7.73	34.50	31.11	54.00	-22.89	V
9608.00	19.82	39.31	9.23	34.79	33.57	54.00	-20.43	V
12010.00	poter * A	lpor.	anbotek	Anbotes	Anbo	54.00	Anbot	V
14412.00	Anbot &	Aupor	An botek	Anboli	Ambo	54.00	lek Ant	V
4804.00	30.78	34.04	6.58	34.09	37.31	54.00	-16.69	Yupoter.
7206.00	22.98	37.11	7.73	34.50	33.32	54.00	-20.68	PAH.
9608.00	19.59	39.31	9.23	34.79	33.34	54.00	-20.66	Ηn
12010.00	stek *	botek	Yupore.	Andrek	Anbotek	54.00	Abote	Н
14412.00	*	botek	Aupolei	Vun.	k abote	54.00	P. P. 11.	ote ^K H

Test Results (1GHz-25GHz)

Гest Mode: (CH39			Test	channel: Midd	le		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	37.20	34.38	6.69	34.09	44.18	74.00	-29.82	boteV
7323.00	31.76	37.22	7.78	34.53	42.23	74.00	-31.77	Vap
9764.00	31.41	39.46	9.35	34.80	45.42	74.00	-28.58	V
12205.00	*	stek	abotek p	upor	An	74.00	Aupo	V
14646.00	* Anti	ntek .	nbotek	Anbotek	Ann	74.00	Aupor	v V
4882.00	41.46	34.38	6.69	34.09	48.44	74.00	-25.56	H
7323.00	33.51	37.22	7.78	34.53	43.98	74.00	-30.02	H
9764.00	30.82	39.46	9.35	34.80	44.83	74.00	-29.17	Anboth H
12205.00	* Anbote	Anbo	rek Vi	botek	Anboten	74.00	anbotek	PH
14646.00	tek * Anb	Vek by	100r B	botek	Anborek	74.00	anbotek	H
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	26.05	34.38	6.69	34.09	33.03	54.00	-20.97	V
7323.00	20.47	37.22	7.78	34.53	30.94	54.00	-23.06	V
9764.00	19.55	39.46	9.35	34.80	33.56	54.00	-20.44	V
12205.00	potek * N	lpor.	abotek	Anbotes	Aupo	54.00	Anbot	V
14646.00	Anbot &	Aupor	An botek	Anboth	Anbe	54.00	lek Ant	V
4882.00	30.26	34.38	6.69	34.09	37.24	54.00	-16.76	Anbote.
7323.00	22.63	37.22	7.78	34.53	33.10	54.00	-20.90	P.H.
9764.00	19.27	39.46	9.35	34.80	33.28	54.00	-20.72	Ho
12205.00	stek *	botek	Aupore.	And wotek	Anbotek	54.00	Abote	Н
14646.00	*	botek	Anboten	Vun.	k abote	54.00	P. P. 11.	ote ^K H

Test Results (1GHz-25GHz)

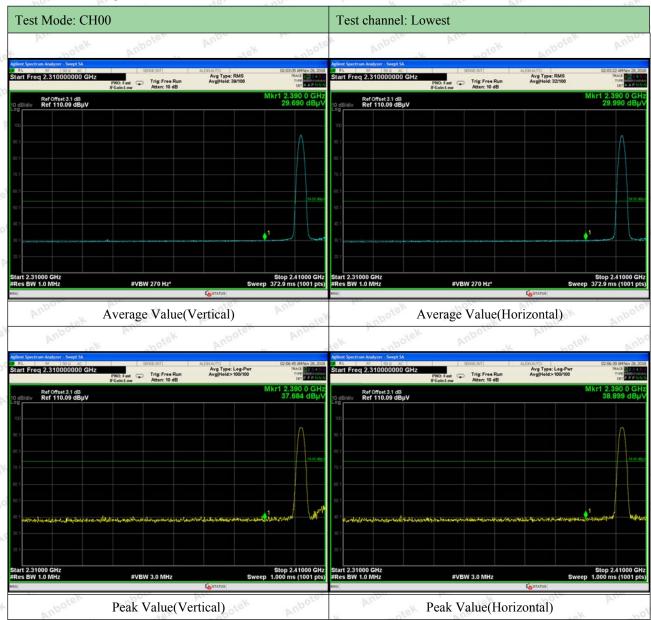
Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	36.61	34.72	6.79	34.09	44.03	74.00	-29.97	boteV
7440.00	31.37	37.34	7.82	34.57	41.96	74.00	-32.04	Vel Vel
9920.00	31.06	39.62	9.46	34.81	45.33	74.00	-28.67	V
12400.00	*	stek	abotek p	upoto	An. spotek	74.00	Anboarek	V
14880.00	*	ntek	nbotek	Aupoter	Pur Potek	74.00	Aupor	e V
4960.00	40.76	34.72	6.79	34.09	48.18	74.00	-25.82	H
7440.00	33.07	37.34	7.82	34.57	43.66	74.00	-30.34	H
9920.00	30.42	39.62	9.46	34.81	44.69	74.00	-29.31	Anbot H
12400.00	* Anbote	Anbo	18K	obotek	Aupolo	74.00	anbotek	Ĥ
14880.00	lek * Anb	View Vi	100, b	abotek	Anbores	74.00	anbotek	H
			A	verage Value	e	0.0		
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.63	34.72	6.79	34.09	33.05	54.00	-20.95	V
7440.00	20.18	37.34	7.82	34.57	30.77	54.00	-23.23	V
9920.00	19.30	39.62	9.46	34.81	33.57	54.00	-20.43	V
12400.00	poter * A	lpo rek	abotek	Anbore	Aug Ofe	54.00	Anbot	V
14880.00	Anbotak	Aupor	A botek	Anbote	MUD	54.00	lek Ant	V
4960.00	29.79	34.72	6.79	34.09	37.21	54.00	-16.79	H
7440.00	22.31	37.34	7.82	34.57	32.90	54.00	-21.10	MA
9920.00	18.98	39.62	9.46	34.81	33.25	54.00	-20.75	Ηn
12400.00	*	potek	Aupor	Andotek	Anbotek	54.00	nbote	Н
14880.00	*	abotek	Anbote	Vie Vie	(hote	54.00	ek w	ote ^K H

Remark

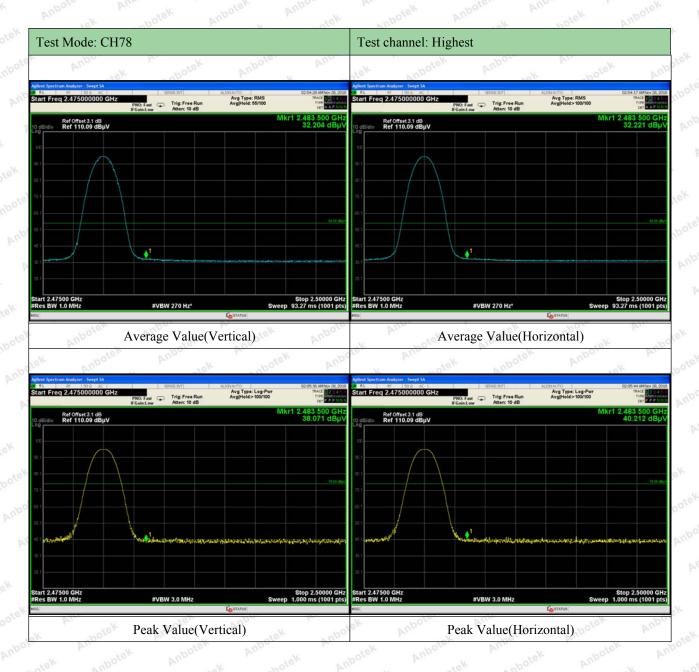
- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.



Radiated Band Edge:







Remark:

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor



5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	247 (b)(3)	Annatek	Anbotek	Anbors	VI.
Test Limit	125mW	a nbotek	Anbote.	Anv	Anbotek	Anbor	r Pr

5.2. Test Setup



5.3. Test Procedure

1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,

2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

 $VBW \ge RBW$

Sweep = auto

Detector function = peak

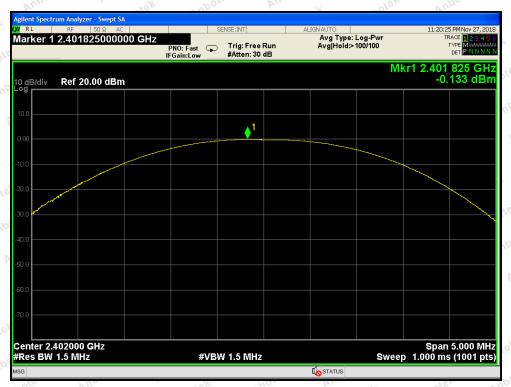
Trace = \max hold

5.4. Test Data

Test Item	:	Max. peak output power	Test Mode :	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature :	24°C
Test Result	:	PASS	Humidity :	55%RH

Channel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results	Modulation
2402	-0.133	20.96	PASS	BDR
2441	-0.490	20.96	PASS	BDR
2480	0.839	20.96	PASS	BDR
2402	0.593	20.96	PASS	EDR
2441	0.232	20.96	PASS	EDR
2480	1.567	20.96	PASS	EDR



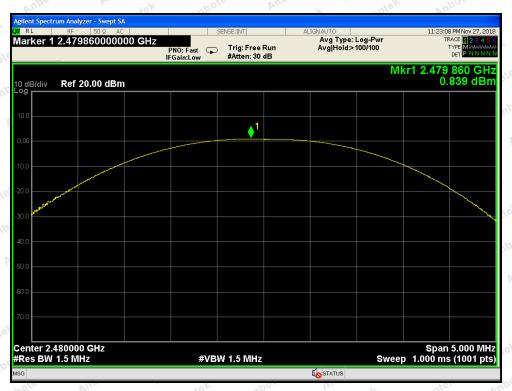


Test Mode: BDR---Low



Test Mode: BDR---Middle



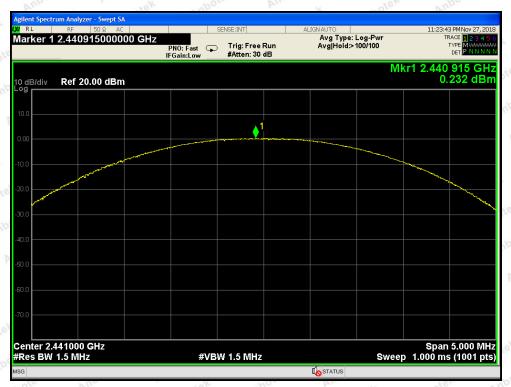


Test Mode: BDR---High

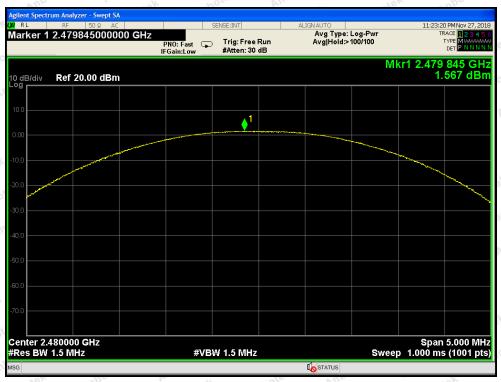


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

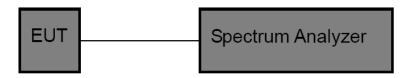


6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Am	potek	Anbo	br.
1 Cot Startaura	1 00 1 milite 0 500 mon 10.2 (, (w)(1)				

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

Test Item : 20dB BW Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V Battery inside Temperature : 24°C

Test Result : PASS Humidity : 55%RH

	1.	VII.	- NO P.	10.
54	Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode
oloo'	Low	2402	880.6	BDR
200	Middle	2441	880.3	BDR
	High Anbox	2480	879.1	BDR Ambouek
	Low	2402	1233	EDR
YS.Y	Middle	2441	1229	EDR
not	High	2480	1232	EDR





Test Mode: BDR---Low



Test Mode: BDR---Middle



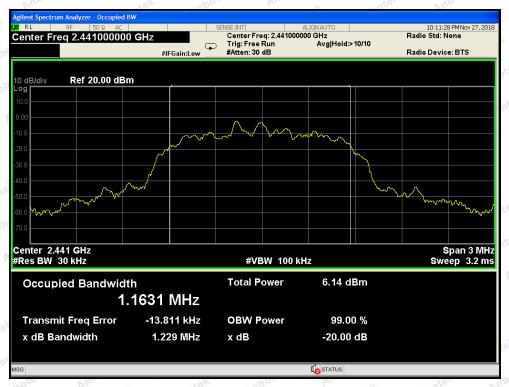


Test Mode: BDR---High

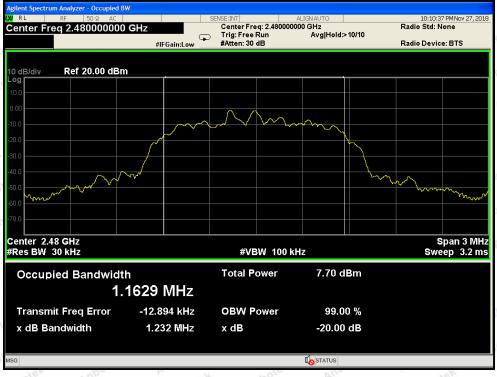


Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

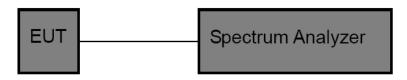


7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

0	Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo	P
	Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anboatek	P

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	24℃
Test Result	:	PASS	Humidity	:	55%RH

Channel	Frequency	Separation Read	Limit	Modulation Mode	
Chamier	(MHz)	Value (kHz)	(kHz)	Wiodulation Wiode	
Low	2402	1000	880.6	BDR	
Middle	2441	1000	880.3	BDR	
High	2480	1000	879.1	nbotek BDRAnbot	
Low	2402	1000	822.0	EDR	
Middle	2441	1000	819.3	EDR	
High	2480	1000	821.3	EDR	
Remark: The limit of	mode (EDR) is 2/3 of 20	dB BW:	Anbo	stek Anbote	



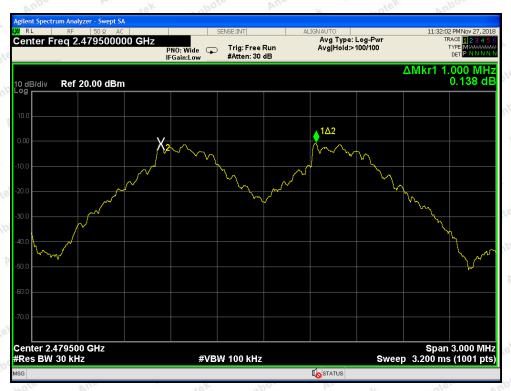


Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

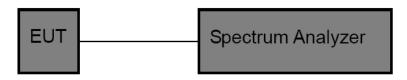


8. Number of Hopping Channel Test

8.1. Test Standard and Limit

je.	Test Standard	FCC Part15 C Section 15.247 (a)(1)		Anbotek	Anbo	p		
	Test Limit	>15 channels	Anbotek	Anboro	An. botek	Anbotek	Anbo	

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

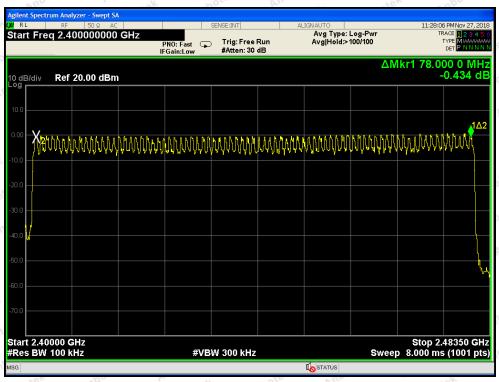
Test Item :	Number of Hopping Frequency	Test Mode :	CH Low ~ CH High
Test Voltage :	DC 3.7V Battery inside	Temperature :	24°C
Test Result :	PASS	Humidity :	55%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel
2402-2480MHz	Ambot Ambot	>15 nboten





BDR Mode



EDR Mode



9. Dwell Time Test

9.1. Test Standard and Limit

Test	Standard	FCC Part15	C Section 15.2	47 (a)(1)	Annabotek	Anbotek	Anbo	p.
Test	Limit	0.4 sec	Anbotek	Anboro	Arr.	Anbotek	Anbo	

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

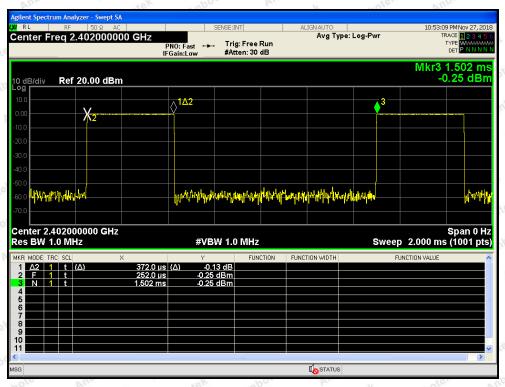
- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = \max hold.
- 7. Allow trace to fully stabilize.

9.4. Test Data

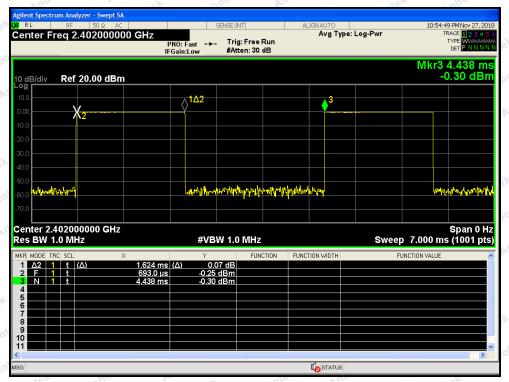
Test Item :	Time of Occupancy	Test Mode :	CH Low ~ CH High
Test Voltage :	DC 3.7V Battery inside	Temperature :	24℃
Test Result :	PASS	Humidity :	55%RH

3	ek abor	All ater and	00	in No	Ore. VUP
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.372	time slot length *1600/2 /79 * 31.6	119.04	0.4	BDR
DH3	1.624	time slot length *1600/4 /79 * 31.6	259.84	0.4	BDR
DH5	2.868	time slot length *1600/6 /79 * 31.6	305.92	0.4	BDR
2DH1	0.380	time slot length *1600/2 /79 * 31.6	121.60	0.4	EDR
2DH3	1.624	time slot length *1600/4 /79 * 31.6	259.84	0.4	EDR
2DH5	2.880	time slot length *1600/6 /79 * 31.6	307.20	0.4	EDR



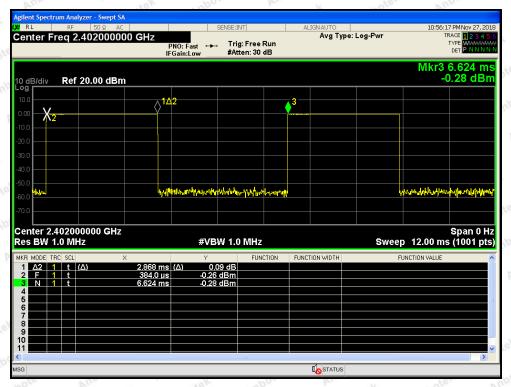


Test Mode: BDR---DH1

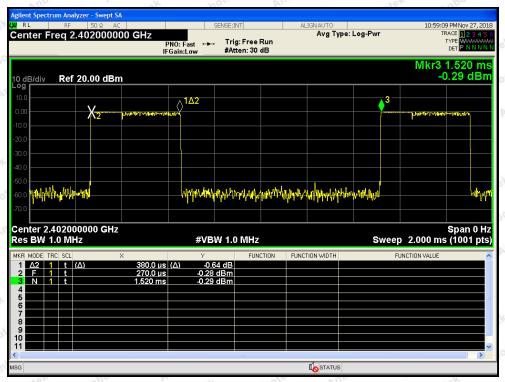


Test Mode: BDR---DH3



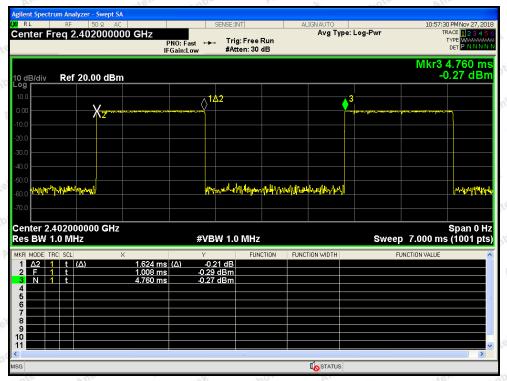


Test Mode: BDR---DH5

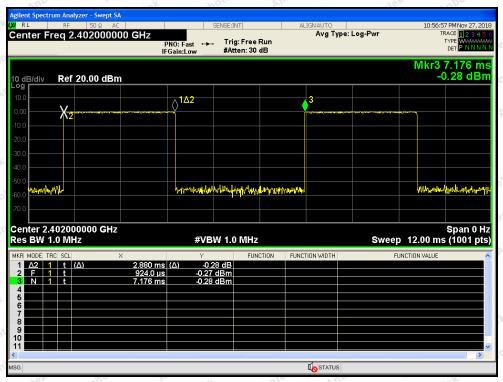


Test Mode: EDR---2DH1





Test Mode: EDR---2DH3



Test Mode: EDR---2DH5



10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.

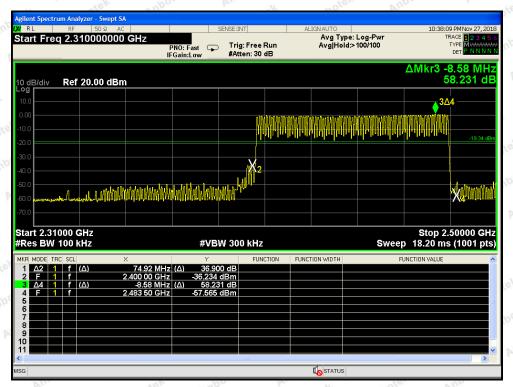
10.4. Test Data

Test Item :	Band edge	Test Mode :	CH Low ~ CH High
Test Voltage :	DC 3.7V Battery inside	Temperature :	24℃
Test Result :	PASS	Humidity :	55%RH

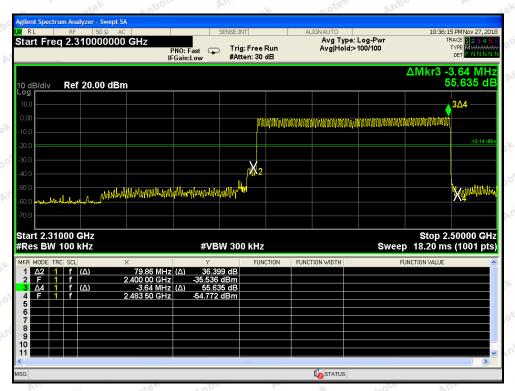
Remark: The EDR was tested on (GFSK, $\pi/4$ QPSK) modes, only the worst data of (GFSK) is attached in the following pages.



For Hopping Mode



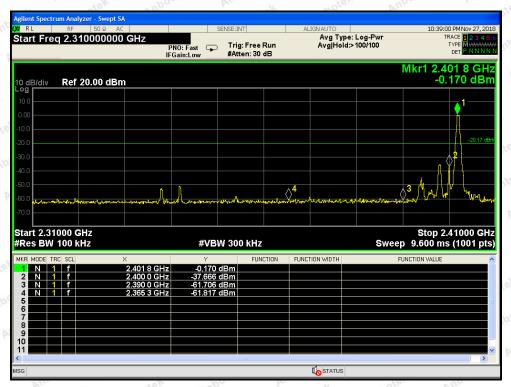
BDR mode



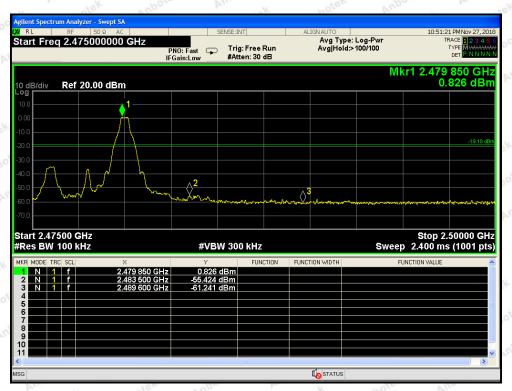
EDR mode



For Non-Hopping Mode



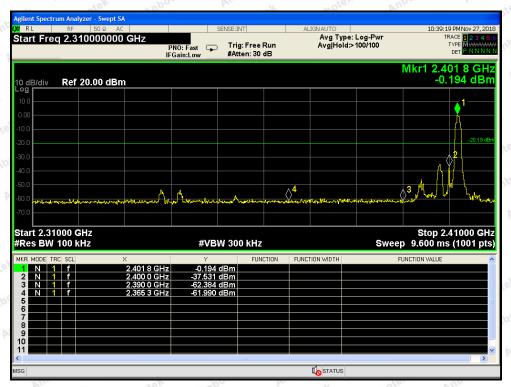
BDR mode -- Lowest



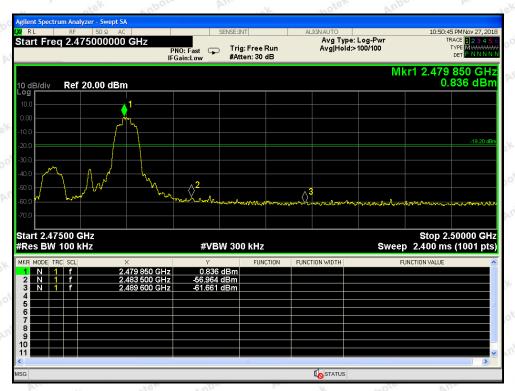
BDR mode -- Highest



For Non-Hopping Mode



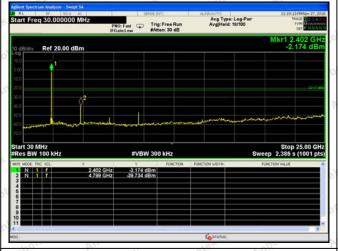
EDR mode -- Lowest

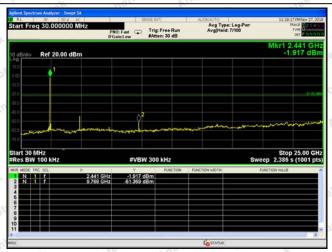


EDR mode -- Highest



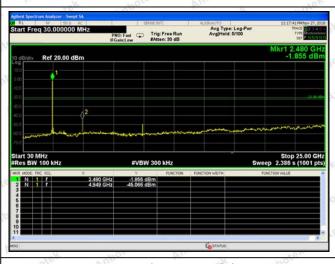
Conducted Emission Method

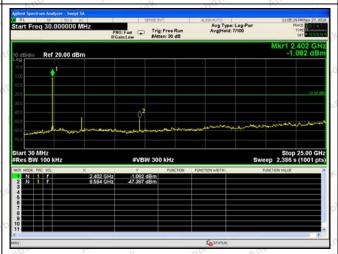




Test Mode: BDR---Low

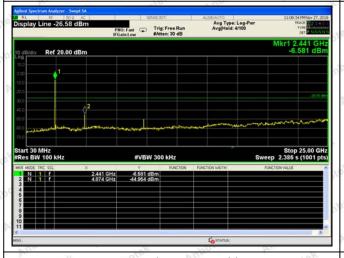
Test Mode: BDR---Mid

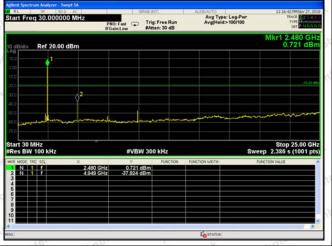




Test Mode: BDR---High







Test Mode: EDR---Mid

Test Mode: EDR---High

Code:AB-RF-05-a



11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)			
	Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek			
	1) 15.203 requirement:			
	An intentional radiator shall be designed to ensure that no antenna other than that furnished			
by the responsible party shall be used with the device. The use of a perman				
	attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the			
	manufacturer may design the unit so that a broken antenna can be replaced by the user, but			
Requirement	the use of a standard antenna jack or electrical connector is prohibited.			
	2) 15.247(c) (1)(i) requirement:			
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed.			
	Point-to-point operations may employ transmitting antennas with directional gain greater			
	than 6dBi provided the maximum conducted output power of the intentional radiator is			
	reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.			

11.2. Antenna Connected Construction

The antenna is PCB Antenna which permanently attached, and the best case gain of the antenna is -3.27 dBi. It complies with the standard requirement.





APPENDIX I -- TEST SETUP PHOTOGRAPH





Photo of Radiation Emission Test









APPENDIX II -- EXTERNAL PHOTOGRAPH



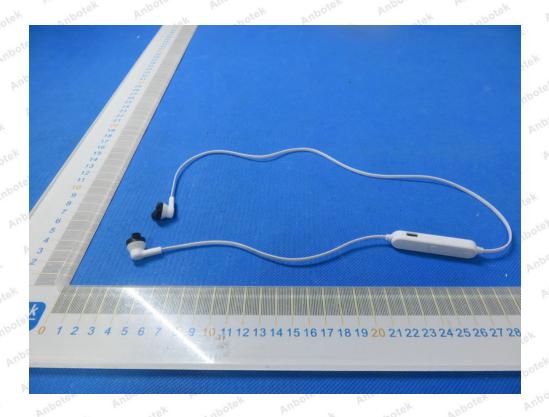










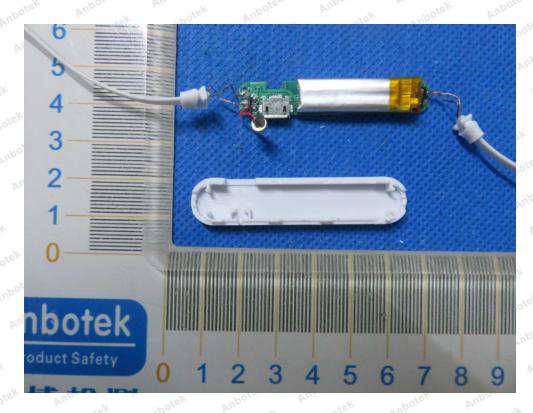




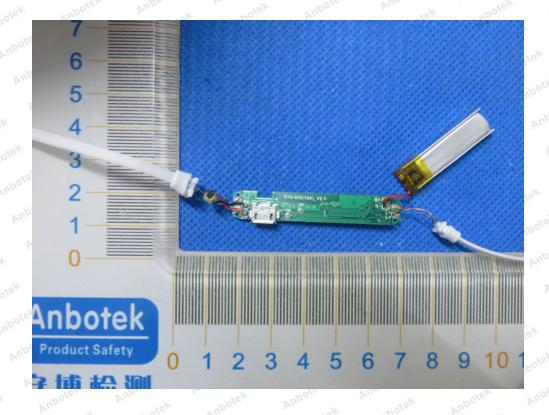


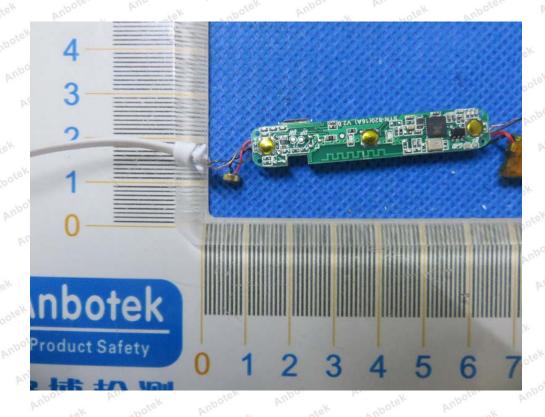
APPENDIX III -- INTERNAL PHOTOGRAPH





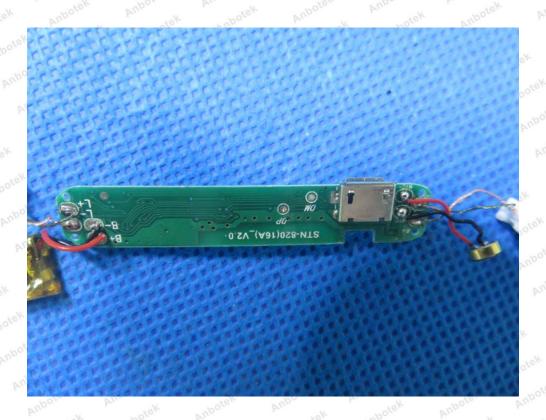












----- End of Report -----